Notice of References Cited Application/Control No. O9/666,280 Examiner Oanh Duong Applicant(s)/Patent Under Reexamination YOON ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,279,007	08-2001	Uppala, Radha Krishna	707/101
	В	US-5,945,988	08-1999	Williams et al.	715/747
	С	US-6,236,395	05-2001	Sezan et al.	715/723
	D	US-,2002/0026349	02-2002	REILLY et al.	705/14
	Е	US-2003/0004934 A1	01-2003	Qian, Richard	707/3
	F	US-2004/0128301 A1	07-2004	Thint et al.	707/101
	G	US-			
	Н	US-			
	1	US-			
	J	US-		`	
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0		·			
	Р	×	:			
	Ω				·	
	R					
	S					
	Т				,	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w	v ·				
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.